

# UPA1970TE-VB Datasheet Dual N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY							
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)				
20	0.022 at V <sub>GS</sub> = 4.5 V	6.0	1.8 nC				
	0.028 at V <sub>GS</sub> = 2.5 V	5.0	1.0110				

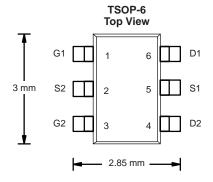
#### **FEATURES**

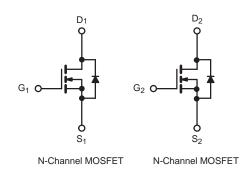
 Halogen-free According to IEC 61249-2-21 Definition



RoHS

- Trench Power MOSFET
- 100 % R<sub>g</sub> Tested
- Compliant to RoHS Directive 2002/95/EC





Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	$V_{DS}$	20	V		
Gate-Source Voltage		$V_{GS}$	± 12	V	
	T <sub>C</sub> = 25 °C		6.0		
Continuous Drain Current (T <sub>.I</sub> = 150 °C)	T <sub>C</sub> = 70 °C	] [	4.0		
Continuous Diam Current (1) = 150 °C)	T <sub>A</sub> = 25 °C	'p	3.5 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	1	2.8 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	18		
	T <sub>C</sub> = 25 °C		1.17		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	Is	0.95 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		1.6		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	1.0	w	
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	1 '0 [	1.14 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C	1	0.73 <sup>b, c</sup>		
Operating Junction and Storage Temperatur	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	აი		
Soldering Recommendations (Peak Tempera		260			

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 5 s	$R_{thJA}$	93	110	°C/W		
Maximum Junction-to-Foot	Steady State	$R_{thJF}$	75	90	S/ V V		

#### Notes:

- a.  $T_C = 25$  °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. Maximum under steady state conditions is 150 °C/W.



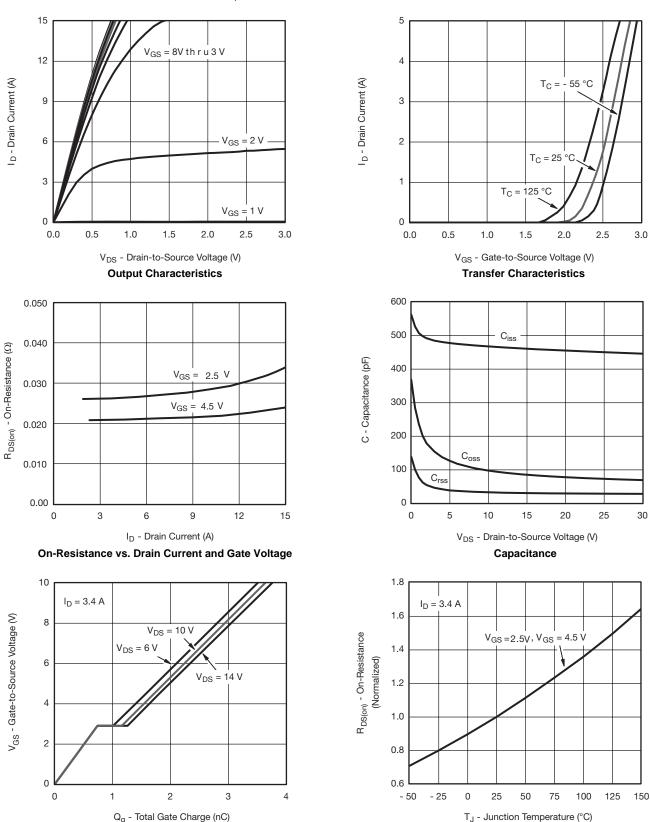
Parameter Syn		Symbol Test Conditions			Max.	Unit
Static						•
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, } I_D = 250  \mu\text{A}$	20			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 250 μA		29		m\//0C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 4		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	0.4		1.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V			1	μΑ
	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	10			Α
		$V_{GS} = 4.5 \text{ V}, I_D = 3.4 \text{ A}$		0.022		Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 2.5 \text{ V}, I_D = 3.0 \text{ A}$		0.028		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_D = 3.4 \text{ A}$		10		S
Dynamic <sup>b</sup>					l 	l .
Input Capacitance	C <sub>iss</sub>			400		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		55		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			26		
Total Gate Charge	Q <sub>g</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3.4 \text{ A}$		3.7	6	nC
				1.8	3	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 3.4 \text{ A}$		0.74		
Gate-Drain Charge	Q <sub>gd</sub>			0.42		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	1	5	10	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			10	20	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = 10 V, $R_L$ = 5.6 $\Omega$		15	30	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 2.7$ A, $V_{GEN}$ = 4.5 V, $R_g$ = 1 $\Omega$		10	20	
Fall Time	t <sub>f</sub>			10	20	
Turn-On Delay Time	t <sub>d(on)</sub>			5	10	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 10 V, $R_L$ = 5.6 $\Omega$		15	30	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 2.7$ A, $V_{GEN}$ = 10 V, $R_g$ = 1 $\Omega$		10	20	
Fall Time	t <sub>f</sub>			10	20	
<b>Drain-Source Body Diode Characteristi</b>	cs				L	
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C		1.2		A
Pulse Diode Forward Current	I <sub>SM</sub>			18		
Body Diode Voltage	$V_{SD}$	$I_S = 2.7 \text{ A}, V_{GS} = 0 \text{ V}$		0.85	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			10	20	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L_ = 2.7 A dl/dt = 100 A/vo T = 25 °C		4	10	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 2.7 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		6		
Reverse Recovery Rise Time	t <sub>b</sub>			4		ns

#### Notes:

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



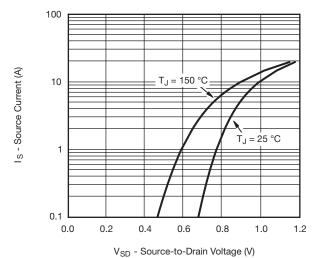


服务热线:400-655-8788

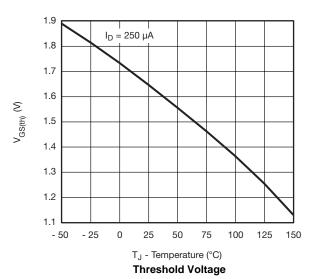
**Gate Charge** 

On-Resistance vs. Junction Temperature



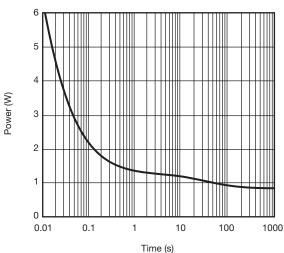


Source-Drain Diode Forward Voltage

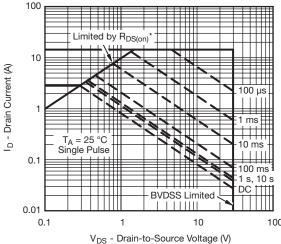


0.14  $I_{D} = 3.4 A$ 0.12 R<sub>DS(on)</sub> - On-Resistance (Ω) 0.10 T<sub>J</sub> = 125 °C 0.08 0.06  $T_J = 25 \, ^{\circ}C$ 0.04 0.02 0.00 0 8 10 V<sub>GS</sub> - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage



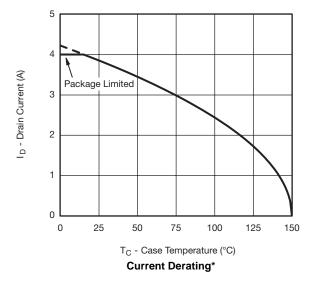
Single Pulse Power (Junction-to-Ambient)

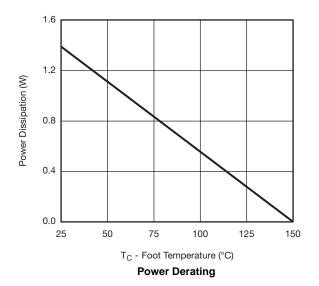


\* V<sub>GS</sub> > minimum V<sub>GS</sub> at which R<sub>DS(on)</sub> is specified

Safe Operating Area, Junction-to-Ambient

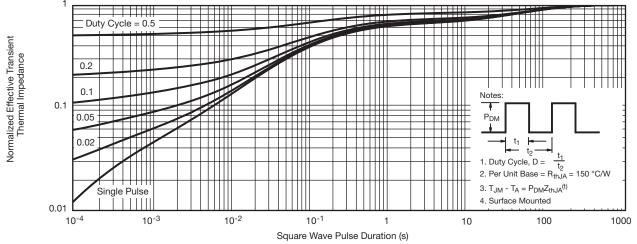




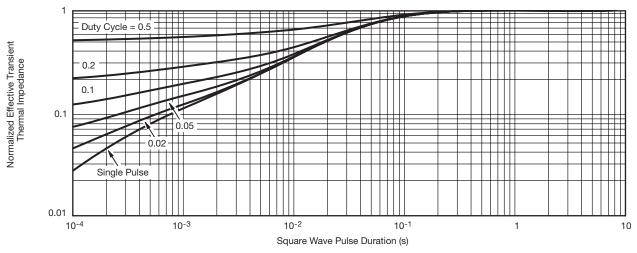


<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



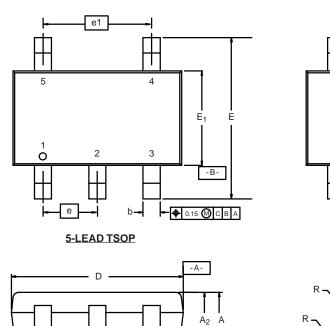
Normalized Thermal Transient Impedance, Junction-to-Foot

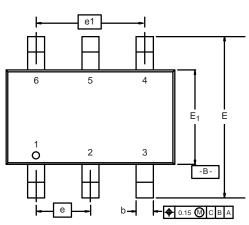


TSOP: 5/6-LEAD

**JEDEC Part Number: MO-193C** 

**a** 0.08 C





**6-LEAD TSOP** 

4x θ1 - 0.17 Ref L<sub>2</sub> Gauge Plane - Seating Plane  $(L_1)$ 4x θ1

	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	-	1.10	0.036	-	0.043	
A <sub>1</sub>	0.01	-	0.10	0.0004	-	0.004	
A <sub>2</sub>	0.90	-	1.00	0.035	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013	0.018	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	2.70	2.85	2.98	0.106	0.112	0.117	
E <sub>1</sub>	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.95 BSC			0.0374 BSC			
e <sub>1</sub>	1.80	1.90	2.00	0.071	0.075	0.079	
L	0.32	-	0.50	0.012	-	0.020	
L <sub>1</sub>	0.60 Ref			0.024 Ref			
L <sub>2</sub>	0.25 BSC			0.010 BSC			
R	0.10	-	-	0.004	-	-	
θ	0°	4°	8°	0°	4°	8°	
$\theta_1$	7° Nom			7° Nom			

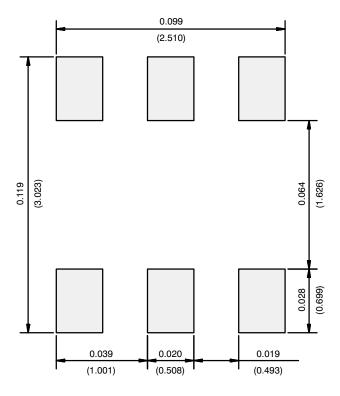
Seating Plane

A<sub>1</sub> -C-

ECN: C-06593-Rev. I, 18-Dec-06 DWG: 5540



### **RECOMMENDED MINIMUM PADS FOR TSOP-6**



Recommended Minimum Pads Dimensions in Inches/(mm)



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